


<b>Search Notes</b>  	<b>Application/Control No.</b>  10815419	<b>Applicant(s)/Patent Under Reexamination</b>  HONJO ET AL.
	<b>Examiner</b>  CHRISTINE CHEN	<b>Art Unit</b>  1793

SEARCHED			
Class	Subclass	Date	Examiner
423	210	5/15/2008	CC
422	177,171,172	5/15/2008	CC
423	210	3/2009	YT

SEARCH NOTES		
Search Notes	Date	Examiner
PALM inventor name search	5/15/08	CC
EAST - see search history	5/15/08	CC
Asked Wayne Langel which class/subclass to search (he suggested 423/210)	5/15/08	CC
Inventor search	3/2009	YT
Internet search	3/2009	YT
EAST text search (US Pat, PG Pub, JPO, EPO, Derwent)	3/2009	YT
Interference search (see supra)	3/2009	YT

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

/YOSHITOSHI TAKEUCHI/  
Examiner, Art Unit 1793